

# XP132A1275SR

ETR1108\_001

Power MOSFET

## ■GENERAL DESCRIPTION

The XP132A1275SR is a P-channel Power MOSFET with low on-state resistance and ultra high-speed switching characteristics.

Because high-speed switching is possible, the IC can be efficiently set thereby saving energy.

The small SOP-8 package makes high density mounting possible.

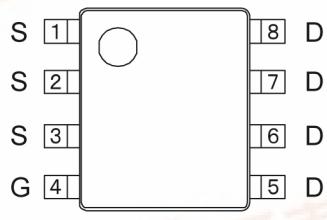
## ■APPLICATIONS

- Notebook PCs
- Cellular and portable phones
- On-board power supplies
- Li-ion battery systems

## ■FEATURES

- Low On-State Resistance** :  $R_{ds(on)}=0.075\Omega$  ( $V_{gs}=-4.5V$ )  
:  $R_{ds(on)}=0.115\Omega$  ( $V_{gs}=-2.5V$ )
- Ultra High-Speed Switching**
- Driving Voltage** : -2.5V
- P-Channel Power MOSFET**
- DMOS Structure**
- Package** : SOP-8

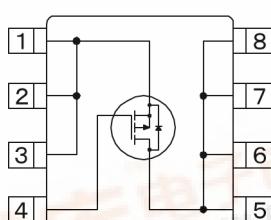
## ■PIN CONFIGURATION

SOP-8  
(TOP VIEW)

## ■PIN ASSIGNMENT

PIN NUMBER	PIN NAME	FUNCTION
1~3	S	Source
4	G	Gate
5~8	D	Drain

## ■EQUIVALENT CIRCUIT

P-channel MOSFET  
(1 device built-in)

## ■ABSOLUTE MAXIMUM RATINGS

 $T_a = 25^\circ C$ 

PARAMETER	SYMBOL	RATINGS	UNITS
Drain-Source Voltage	$V_{dss}$	-20	V
Gate-Source Voltage	$V_{gss}$	$\pm 12$	V
Drain Current (DC)	$I_d$	-5	A
Drain Current (Pulse)	$I_{dp}$	-20	A
Reverse Drain Current	$I_{dr}$	-5	A
Channel Power Dissipation *	$P_d$	2.5	W
Channel Temperature	$T_{ch}$	150	°C
Storage Temperature Range	$T_{stg}$	-55~150	°C

\* When implemented on a glass epoxy PCB

# XP132A1275SR

## ■ ELECTRICAL CHARACTERISTICS

### DC Characteristics

T<sub>a</sub> = 25°C

PARAMETER	SYMBOL	CONDITIONS	MIN.	TYP.	MAX.	UNITS
Drain Cut-Off Current	I <sub>dss</sub>	V <sub>ds</sub> =-20V, V <sub>gs</sub> =0V	-	-	-10	μA
Gate-Source Leak Current	I <sub>gss</sub>	V <sub>gs</sub> =±12V, V <sub>ds</sub> =0V	-	-	±1	μA
Gate-Source Cut-Off Voltage	V <sub>gs(off)</sub>	I <sub>d</sub> =-1mA, V <sub>ds</sub> =-10V	-0.5	-	-1.2	V
Drain-Source On-State Resistance *	R <sub>ds(on)</sub>	I <sub>d</sub> =-3A, V <sub>gs</sub> =-4.5V	-	0.06	0.075	Ω
		I <sub>d</sub> =-3A, V <sub>gs</sub> =-2.5V	-	0.092	0.115	Ω
Forward Transfer Admittance *	Y <sub>fs</sub>	I <sub>d</sub> =-3A, V <sub>ds</sub> =-10V	-	8	-	S
Body Drain Diode Forward Voltage	V <sub>f</sub>	I <sub>f</sub> =-5A, V <sub>gs</sub> =0V	-	-0.85	-1.1	V

\* Effective during pulse test.

### Dynamic Characteristics

T<sub>a</sub> = 25°C

PARAMETER	SYMBOL	CONDITIONS	MIN.	TYP.	MAX.	UNITS
Input Capacitance	C <sub>iss</sub>	V <sub>ds</sub> =-10V, V <sub>gs</sub> =0V f=1MHz	-	770	-	pF
Output Capacitance	C <sub>oss</sub>		-	440	-	pF
Feedback Capacitance	C <sub>rss</sub>		-	180	-	pF

### Switching Characteristics

T<sub>a</sub> = 25°C

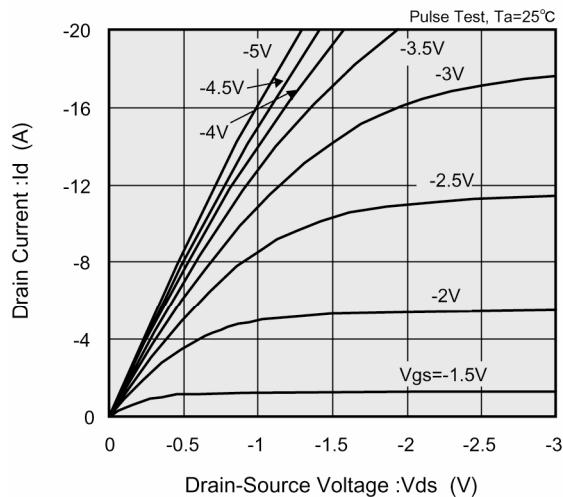
PARAMETER	SYMBOL	CONDITIONS	MIN.	TYP.	MAX.	UNITS
Turn-On Delay Time	t <sub>d</sub> (on)	V <sub>gs</sub> =-5V, I <sub>d</sub> =-3A V <sub>dd</sub> =-10V	-	10	-	ns
Rise Time	t <sub>r</sub>		-	25	-	ns
Turn-Off Delay Time	t <sub>d</sub> (off)		-	45	-	ns
Fall Time	t <sub>f</sub>		-	40	-	ns

### Thermal Characteristics

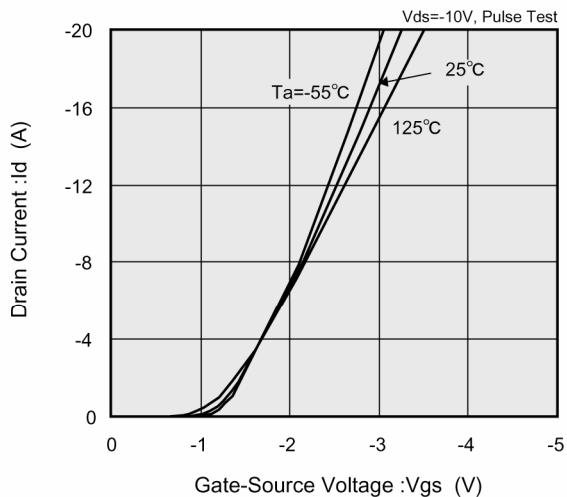
PARAMETER	SYMBOL	CONDITIONS	MIN.	TYP.	MAX.	UNITS
Thermal Resistance (Channel-Ambience)	R <sub>th</sub> (ch-a)	Implement on a glass epoxy resin PCB	-	50	-	°C/W

## ■ TYPICAL PERFORMANCE CHARACTERISTICS

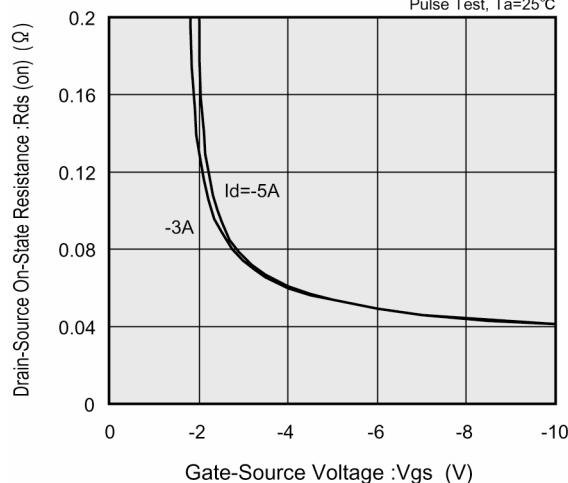
(1) Drain Current vs. Drain-Source Voltage



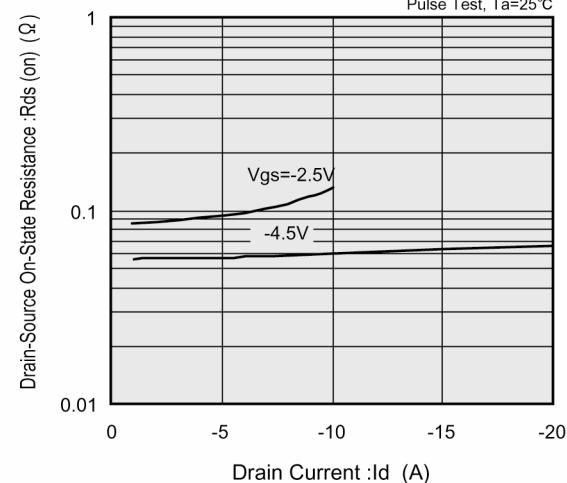
(2) Drain Current vs. Gate-Source Voltage



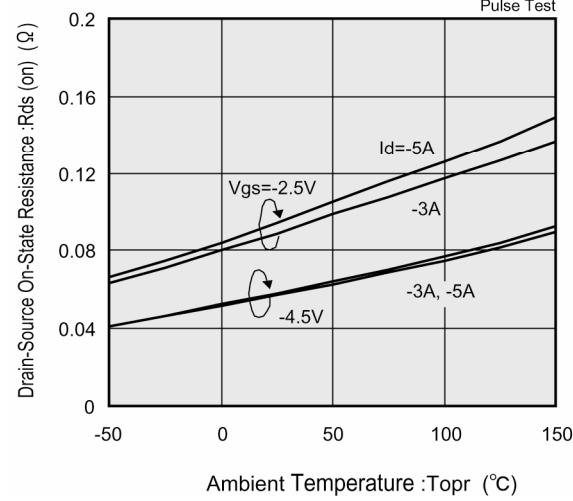
(3) Drain-Source On-State Resistance vs. Gate-Source Voltage



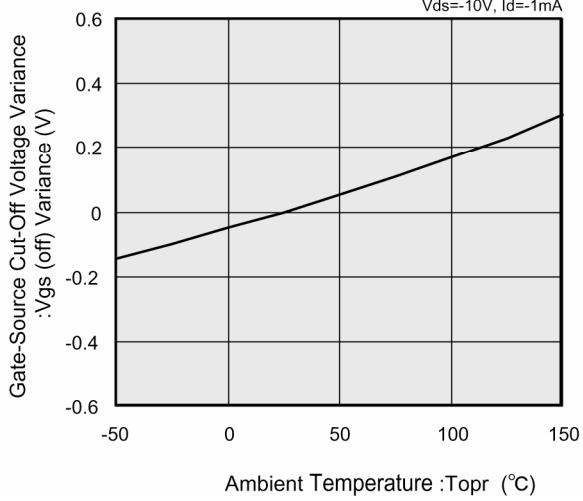
(4) Drain-Source On-State Resistance vs. Drain Current



(5) Drain-Source On-State Resistance vs. Ambient Temperature



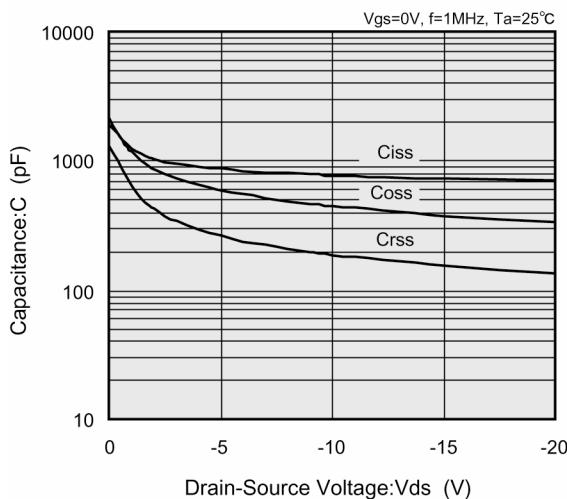
(6) Gate-Source Cut-Off Voltage Variance vs. Ambient Temperature



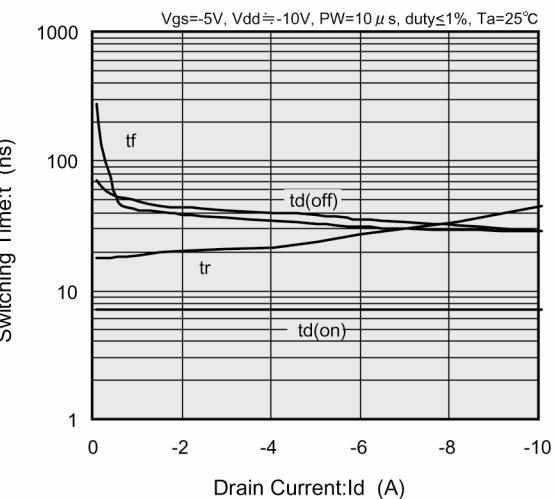
# XP132A1275SR

## ■ TYPICAL PERFORMANCE CHARACTERISTICS (Continued)

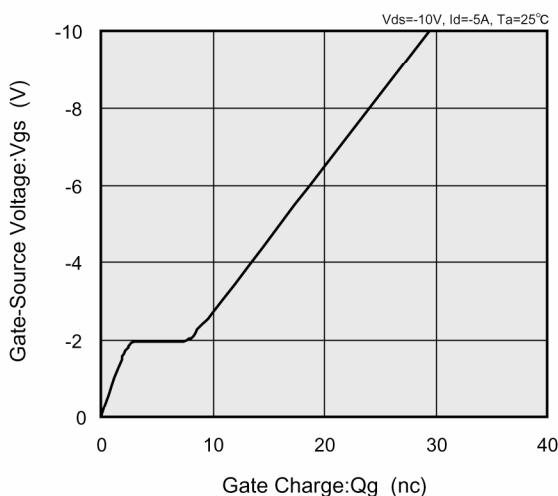
(7) Capacitance vs. Drain-Source Voltage



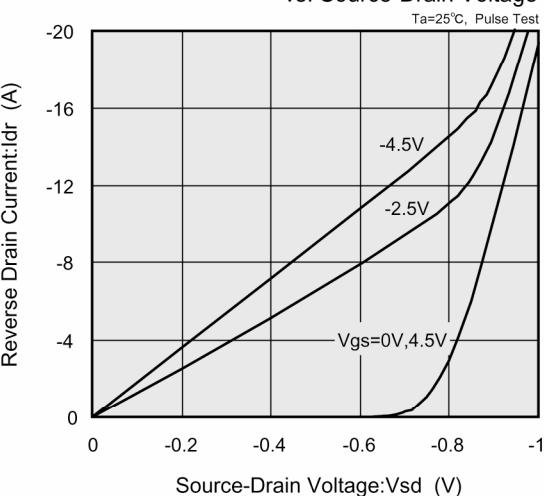
(8) Switching Time vs. Drain Current



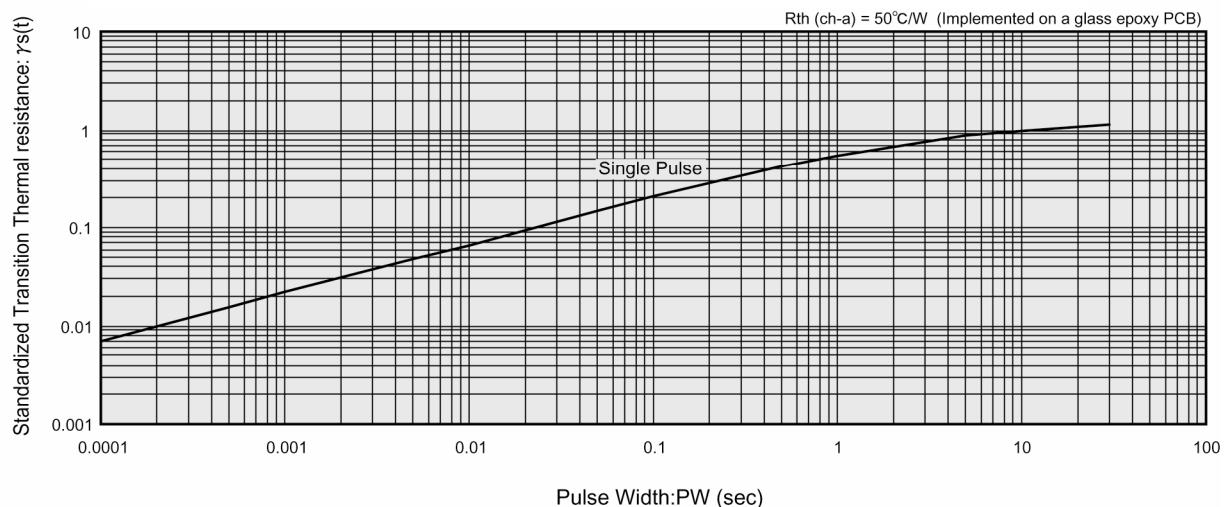
(9) Gate-Source Voltage vs. Gate Charge



(10) Reverse Drain Current vs. Source-Drain Voltage



(11) Standardized transition Thermal Resistance vs. Pulse Width



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